

**Notice of References Cited**

Application/Control No.

10/518,475

Applicant(s)/Patent Under  
Reexamination  
LING ET AL.

Examiner

Emmanuel S. Luk

Art Unit

1791

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,120,995	10-1978	Phipps et al.	427/255.23
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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